

Search Notes

Application/Control No.

10/672,809

Examiner

Paul D. Kim

Applicant(s)/Patent under
Reexamination

LIN ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.07 603.11 603.13- 603.16	4/21/2006	PK
	603.18		
360	316 324.1		
	324.11		
	324.12		
	324.2		
216	22,48		
427	127 128	✓	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed Parent Application 10/118,407 (US PT. 6,989,971)	4/21/2006	PK
Text Search EAST/ NPL (IEEE)	4/21/2006	PK